# **HEF4047B**

### Monostable/astable multivibrator

Rev. 4 — 15 September 2014

**Product data sheet** 

### 1. General description

The HEF4047B consists of a gatable astable multivibrator incorporating logic techniques to permit positive or negative edge-triggered monostable multivibrator action with retriggering and external counting options.

Inputs include +TRIGGER, –TRIGGER, <u>ASTABLE</u>, ASTABLE, RETRIGGER and MR (master reset). Buffered outputs are O,  $\overline{O}$  and OSCILLATOR OUTPUT. In all modes of operation an external capacitor ( $C_t$ ) must be connected between CTC and RCTC, and an external resistor ( $R_t$ ) must be connected between RTC and RCTC.

A HIGH level on the ASTABLE input enables a stable operation. The period of the square wave at O and  $\overline{O}$  outputs is a function of the external components employed. 'True' input pulses on the ASTABLE or 'complement' pulses on the  $\overline{ASTABLE}$  input, allow the circuit to be used as a gatable multivibrator. The OSCILLATOR OUTPUT period is half of the O output in the astable mode. However, a 50% duty factor is not guaranteed at this output.

In the monostable mode, positive edge-triggering is accomplished by applying a leading-edge pulse to the +TRIGGER input and a LOW level to the -TRIGGER input. For negative edge-triggering, a trailing-edge pulse is applied to the -TRIGGER and a HIGH level to the +TRIGGER. Input pulses may be of any duration relative to the output pulse. The multivibrator can be retriggered (on the leading-edge only) by applying a common pulse to both the RETRIGGER and +TRIGGER inputs. In this mode, the output pulse remains HIGH as long as the input pulse period is shorter than the period determined by the RC components.

An external count down option implements coupling O to an external 'N' counter and resetting the counter with the trigger pulse. The counter output pulse is fed back to the  $\overline{\mathsf{ASTABLE}}$  input and has a duration equal to N times the period of the multivibrator. A HIGH level on the MR input assures no output pulse during an ON-power condition. This input can also be activated to terminate the output pulse at any time. In the monostable mode, a HIGH level or power-ON reset pulse must be applied to MR, whenever  $V_{DD}$  is applied.

### 2. Features and benefits

#### 2.1 General

- Monostable (one-shot) or a stable (free-running) operation
- True and complemented buffered outputs
- Only one external resistor and capacitor required



### 2.2 Monostable multivibrator

- Positive- or negative-edge triggering
- Output pulse width independent of trigger pulse duration
- Retriggerable option for pulse-width expansion
- Long pulse width possible using small RC components with external counter provision
- Fast recovery time independent of pulse width
- Pulse-width accuracy maintained at duty cycles approaching 100%

### 2.3 Astable multivibrator

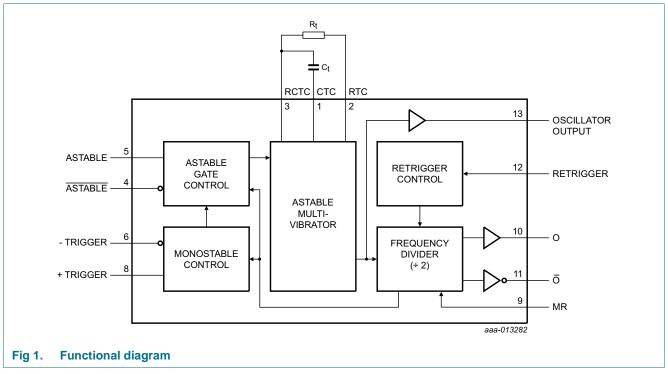
- Free-running or gatable operating modes
- 50% duty cycle
- Oscillator output available

## 3. Ordering information

Table 1. Ordering information

Type number	Package		
	Name	Description	Version
HEF4047BP	DIP14	plastic dual in-line package; 14 leads (300 mil)	SOT27-1
HEF4047BT	SO14	plastic small outline package; 14 leads; body width 3.9 mm	SOT108-1

### 4. Functional diagram

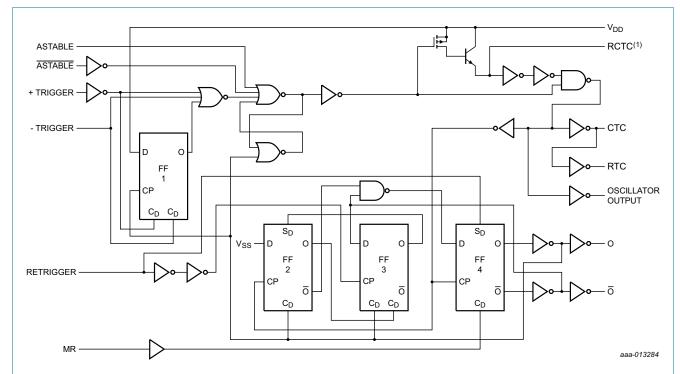


HEF4047B

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### Monostable/astable multivibrator

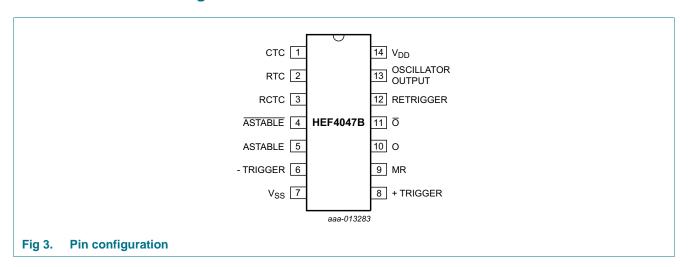


(1) Special input protection that allows operating input voltages outside the supply voltage lines. Compared to the standard input protection pin 3 (RCTC) is more sensitive to static discharge; extra handling precautions are recommended.

Fig 2. Logic diagram

# 5. Pinning information

### 5.1 Pinning



### 5.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
CTC	1	external capacitor connection
RTC	2	external resistor connection
RCTC	3	external capacitor/resistor connection
ASTABLE	4	input
ASTABLE	5	input
-TRIGGER	6	input
V <sub>SS</sub>	7	ground supply voltage
+TRIGGER	8	input
MR	9	master reset input
0	10	output
ō	11	output
RETRIGGER	12	input
OSCILLATOR OUTPUT	13	oscillator output
$V_{DD}$	14	supply voltage

# 6. Limiting values

Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DD}$	supply voltage		-0.5	+18	V
I <sub>IK</sub>	input clamping current	$V_{I} < -0.5 \text{ V or } V_{I} > V_{DD} + 0.5 \text{ V}$	-	±10	mA
VI	input voltage		-0.5	V <sub>DD</sub> + 0.5	V
I <sub>OK</sub>	output clamping current	$V_O < -0.5 \text{ V or } V_O > V_{DD} + 0.5 \text{ V}$	-	±10	mA
I <sub>I/O</sub>	input/output current		-	±10	mA
I <sub>DD</sub>	supply current		-	50	mA
T <sub>stg</sub>	storage temperature		-65	+150	°C
T <sub>amb</sub>	ambient temperature		-40	+85	°C
P <sub>tot</sub>	total power dissipation	$T_{amb} = -40  ^{\circ}\text{C} \text{ to } +85  ^{\circ}\text{C}$			
		DIP14 package	-	750	mW
		SO14 package	-	500	mW
Р	power dissipation	per output	-	100	mW

<sup>[1]</sup> For DIP14 package:  $P_{tot}$  derates linearly with 12 mW/K above 70 °C.

<sup>[2]</sup> For SO14 package:  $P_{tot}$  derates linearly with 8 mW/K above 70 °C.

### Monostable/astable multivibrator

# 7. Recommended operating conditions

Table 4. Operating conditions

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DD}$	supply voltage		3	15	V
V <sub>I</sub>	input voltage		0	$V_{DD}$	V
T <sub>amb</sub>	ambient temperature	in free air	-40	+85	°C
Δt/ΔV	input transition rise and fall	V <sub>DD</sub> = 5 V	-	3.75	μs/V
	rate	V <sub>DD</sub> = 10 V	-	0.5	μs/V
		V <sub>DD</sub> = 15 V	-	0.08	μs/V

## 8. Static characteristics

### Table 5. Static characteristics

 $V_{SS} = 0 \ V$ ;  $V_I = V_{SS}$  or  $V_{DD}$  unless otherwise specified.

Symbol	Parameter	Conditions	$V_{DD}$	T <sub>amb</sub> =	T <sub>amb</sub> = -40 °C		25 °C	T <sub>amb</sub> = 85 °C		Unit
				Min	Max	Min	Max	Min	Max	
$V_{IH}$	V <sub>IH</sub> HIGH-level input voltage	I <sub>O</sub>   < 1 μA	5 V	3.5	-	3.5	-	3.5	-	V
			10 V	7.0	-	7.0	-	7.0	-	V
			15 V	11.0	-	11.0	-	11.0	-	V
$V_{IL}$	LOW-level input voltage	I <sub>O</sub>   < 1 μA	5 V	-	1.5	-	1.5	-	1.5	V
	LOW-level input voltage		10 V	-	3.0	-	3.0	-	3.0	V
			15 V	-	4.0	-	4.0	-	4.0	V
V <sub>OH</sub>	HIGH-level output voltage	I <sub>O</sub>   < 1 μA	5 V	4.95	-	4.95	-	4.95	-	V
			10 V	9.95	-	9.95	-	9.95	-	V
			15 V	14.95	-	14.95	-	14.95	-	V
$V_{OL}$	LOW-level output voltage	I <sub>O</sub>   < 1 μA	5 V	-	0.05	-	0.05	-	0.05	V
			10 V	-	0.05	-	0.05	-	0.05	V
			15 V	-	0.05	-	0.05	-	0.05	V
I <sub>OH</sub>	HIGH-level output current	V <sub>O</sub> = 2.5 V	5 V	-	-1.7	-	-1.4	-	-1.1	mA
		V <sub>O</sub> = 4.6 V	5 V	-	-0.52	-	-0.44	-	-0.36	mA
		V <sub>O</sub> = 9.5 V	10 V	-	-1.3	-	-1.1	-	-0.9	mA
		V <sub>O</sub> = 13.5 V	15 V	-	-3.6	-	-3.0	-	-2.4	mA
I <sub>OL</sub>	LOW-level output current	V <sub>O</sub> = 0.4 V	5 V	0.52	-	0.44	-	0.36	-	mA
		V <sub>O</sub> = 0.5 V	10 V	1.3	-	1.1	-	0.9	-	mA
		V <sub>O</sub> = 1.5 V	15 V	3.6	-	3.0	-	2.4	-	mA
I <sub>I</sub>	input leakage current		15 V	-	±0.3	-	±0.3	-	±1.0	μΑ
		output transistor OFF; pin 3 at V <sub>DD</sub> or V <sub>SS</sub>	15 V	-	±0.3	-	±0.3	-	±1.0	μА
I <sub>DD</sub>	supply current	I <sub>O</sub> = 0 A	5 V	-	20	-	20	-	150	μΑ
			10 V	-	40	-	40	-	300	μΑ
			15 V	-	80	-	80	-	600	μΑ
Cı	input capacitance		-	-	-	-	7.5	-	-	pF

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# 9. Dynamic characteristics

Table 6. Dynamic characteristics

 $V_{SS} = 0 \text{ V}$ ;  $T_{amb} = 25 \text{ °C}$ ; for test circuit and waveform, see <u>Figure 4</u> and <u>Figure 5</u>; unless otherwise specified.

Symbol	Parameter	Conditions	$V_{DD}$		Extrapolation formula	Min	Тур	Max	Unit
t <sub>PHL</sub>	HIGH to LOW	ASTABLE, ASTABLE	5 V	[1]	68 ns + (0.55 ns/pF)C <sub>L</sub>	-	95	190	ns
	propagation delay	to OSCILLATOR OUTPUT	10 V	[1]	43 ns + (0.23 ns/pF)C <sub>L</sub>	-	45	90	ns
		OUTFUT	15 V	[1]	22 ns + (0.16 ns/pF)C <sub>L</sub>	-	30	60	ns
t <sub>PLH</sub>	LOW to HIGH	ASTABLE, ASTABLE	5 V	[1]	58 ns + (0.55 ns/pF)C <sub>L</sub>	-	85	170	ns
	propagation delay	to OSCILLATOR OUTPUT	10 V		29 ns + (0.23 ns/pF)C <sub>L</sub>	-	40	80	ns
		0011 01	15 V		22 ns + (0.16 ns/pF)C <sub>L</sub>	-	30	60	ns
t <sub>PHL</sub>	HIGH to LOW	ASTABLE, ASTABLE	5 V	[1]	123 ns + (0.55 ns/pF)C <sub>L</sub>	-	150	300	ns
	propagation delay	to O, O	10 V		54 ns + (0.23 ns/pF)C <sub>L</sub>	-	65	130	ns
			15 V		42 ns + (0.16 ns/pF)C <sub>L</sub>	-	50	100	ns
t <sub>PLH</sub>	LOW to HIGH	ASTABLE, ASTABLE	5 V	[1]	103 ns + (0.55 ns/pF)C <sub>L</sub>	-	130	260	ns
	propagation delay	to O, O	10 V		49 ns + (0.23 ns/pF)C <sub>L</sub>	-	60	120	ns
			15 V		37 ns + (0.16 ns/pF)C <sub>L</sub>	-	45	90	ns
t <sub>PHL</sub>	HIGH to LOW	+/–TRIGGER to O, $\overline{O}$	5 V	[1]	133 ns + (0.55 ns/pF)C <sub>L</sub>	-	160	320	ns
	propagation delay		10 V		54 ns + (0.23 ns/pF)C <sub>L</sub>	-	65	130	ns
			15 V		42 ns + (0.16 ns/pF)C <sub>L</sub>	-	50	100	ns
t <sub>PLH</sub>	LOW to HIGH	+/–TRIGGER to O, $\overline{O}$	5 V	[1]	128 ns + (0.55 ns/pF)C <sub>L</sub>	-	155	310	ns
	propagation delay		10 V		54 ns + (0.23 ns/pF)C <sub>L</sub>	-	65	130	ns
			15 V		42 ns + (0.16 ns/pF)C <sub>L</sub>	-	50	100	ns
t <sub>PHL</sub>	HIGH to LOW	+TRIGGER,	5 V	[1]	38 ns + (0.55 ns/pF)C <sub>L</sub>	-	65	130	ns
	propagation delay	RETRIGGER to O	10 V		19 ns + (0.23 ns/pF)C <sub>L</sub>	-	30	60	ns
			15 V		17 ns + (0.16 ns/pF)C <sub>L</sub>	-	25	50	ns
t <sub>PLH</sub>	LOW to HIGH	+TRIGGER,	5 V	[1]	68 ns + (0.55 ns/pF)C <sub>L</sub>	-	95	190	ns
	propagation delay	RETRIGGER to O	10 V		29 ns + (0.23 ns/pF)C <sub>L</sub>	-	40	80	ns
			15 V		22 ns + (0.16 ns/pF)C <sub>L</sub>	-	30	60	ns
t <sub>PHL</sub>	HIGH to LOW	MR to O	5 V	[1]	83 ns + (0.55 ns/pF)C <sub>L</sub>	-	100	200	ns
	propagation delay		10 V		34 ns + (0.23 ns/pF)C <sub>L</sub>	-	45	90	ns
			15 V		27 ns + (0.16 ns/pF)C <sub>L</sub>	-	35	70	ns
t <sub>PLH</sub>	LOW to HIGH	MR to O	5 V	[1]	83 ns + (0.55 ns/pF)C <sub>L</sub>	-	100	200	ns
	propagation delay		10 V		34 ns + (0.23 ns/pF)C <sub>L</sub>	-	45	90	ns
			15 V		27 ns + (0.16 ns/pF)C <sub>L</sub>	-	35	70	ns
t <sub>THL</sub>	HIGH to LOW		5 V	[1]	10 ns + (1.0 ns/pF)C <sub>L</sub>	-	60	120	ns
	output transition time		10 V		9 ns + (0.42 ns/pF)C <sub>L</sub>	-	30	60	ns
			15 V		6 ns + (0.28 ns/pF)C <sub>L</sub>	-	20	40	ns
t <sub>TLH</sub>	LOW to HIGH		5 V	[1]	10 ns + (1.0 ns/pF)C <sub>L</sub>	-	60	120	ns
	output transition time		10 V		9 ns + (0.42 ns/pF)C <sub>L</sub>	-	30	60	ns
	uille		15 V		6 ns + (0.28 ns/pF)C <sub>L</sub>	-	20	40	ns

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 Table 6.
 Dynamic characteristics ...continued

 $V_{SS} = 0 \text{ V}$ ;  $T_{amb} = 25 \text{ °C}$ ; for test circuit and waveform, see <u>Figure 4</u> and <u>Figure 5</u>; unless otherwise specified.

Symbol	Parameter	Conditions	$V_{DD}$	Extrapolation formula	Min	Тур	Max	Unit
t <sub>W</sub>	pulse width	any input except MR	5 V	-	220	110	-	ns
			10 V	-	100	50	-	ns
			15 V	-	70	35	-	ns
		MR HIGH	5 V	-	60	30	-	ns
			10 V	-	30	15	-	ns
			15 V	-	20	10	-	ns

<sup>[1]</sup> The typical values of the propagation delay and transition times are calculated from the extrapolation formulas shown ( $C_L$  in pF).

### 10. Waveforms

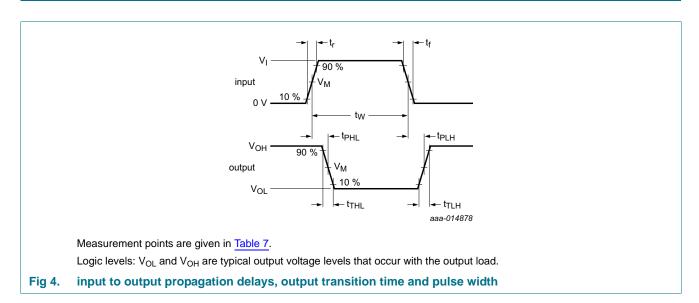
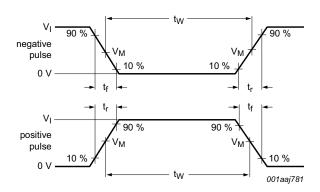


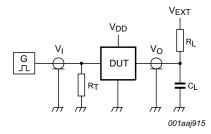
Table 7. Measurement points

Supply voltage	Input	Output
$V_{DD}$	V <sub>M</sub>	V <sub>M</sub>
5 V to 15 V	0.5V <sub>DD</sub>	0.5V <sub>DD</sub>

### Monostable/astable multivibrator



### a. Input waveform



#### b. Test circuit

Test and measurement data is given in Table 8.

Definitions test circuit:

DUT = Device Under Test.

 $R_T$  = Termination resistance should be equal to output impedance  $Z_o$  of the pulse generator.

 $C_L$  = Load capacitance including jig and probe capacitance.

### Fig 5. Test circuit for measuring switching times

Table 8. Test data

Supply voltage	Input		Load		V <sub>EXT</sub>
	VI	t <sub>r</sub> , t <sub>f</sub>	C <sub>L</sub>	R <sub>L</sub>	t <sub>PLH</sub> , t <sub>PHL</sub>
5 V to 15 V	$V_{DD}$	≤ 20 ns	50 pF	1 kΩ	open

# 11. Application information

Table 9. Functional connections [1]

Function	Pi	ns connected	to	Output pulse from	Output period or
	V <sub>DD</sub>	V <sub>SS</sub>	input pulse	pins	pulse width
Astable multivibrator					
Free running	4, 5, 6, 14	7, 8, 9, 12	-	10, 11, 13	at pins 10, 11;
True gating	4, 6, 14	7, 8, 9, 12	5	10, 11, 13	$t_A = 4.40 R_t C_t$ at pin 13:
Complement gating	6, 14	5, 7, 8, 9, 12	4	10, 11, 13	$t_A = 2.20 R_t C_t$

Table 9.	Functional	connections	continued[1]
Table 5.	FullCuoliai	COMPECTIONS	commuea <u></u>

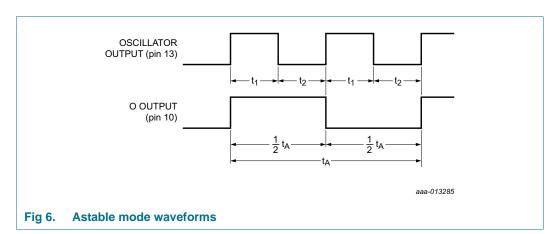
Function	F	Pins connected to			
	$V_{DD}$	V <sub>SS</sub>	input pulse	pins	pulse width
Monostable multivibrator					
Positive edge-triggering	4, 14	5, 6, 7, 9, 12	8	10, 11	at pins 10, 11;
Negative edge-triggering	4, 8, 14	5, 7, 9, 12	6	10, 11	$t_{M} = 2.48 \; R_{t} C_{t}$
Retriggerable	4, 14	5, 6, 7, 9	8, 12	10, 11	
External countdown[2]	14	5, 6, 7, 8, 9, 12	-	10, 11	

- [1] In all cases, external resistor between pins 2 and 3, external capacitor between pins 1 and 3.
- [2] Input pulse to RESET of external counting chip: external counting chip output to pin 4.

### 11.1 Astable mode design information

### 11.1.1 Unit-to-unit transfer voltage variations

The following analysis presents worst case variations from unit-to-unit as a function of transfer voltage  $(V_{TR})$  shift for free running (astable) operation.



$$t_I = -R_t C_t \ln \frac{V_{TR}}{V_{DD} + V_{TR}} \tag{1}$$

$$t_2 = -R_t C_t \ln \frac{V_{DD} - V_{TR}}{2V_{DD} - V_{TR}} \tag{2}$$

$$t_A = 2(t_I + t_2) = -2R_t C_t \ln \frac{(V_{TR})(V_{DD} - V_{TR})}{(V_{DD} + V_{TR})(2V_{DD} - V_{TR})}$$
(3)

, where  $t_A$  = astable mode pulse width; see <u>Table 10</u>.

Table 10. Values for a stable mode pulse width (t<sub>A</sub>)

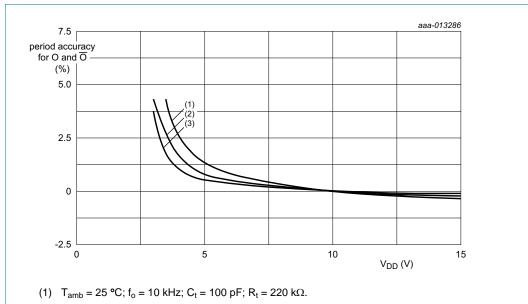
		$V_{TR}$		t <sub>A</sub>					
	Min	Тур	Max	Min	Typ[1]	Max			
V <sub>DD</sub> = 5 V or 10 V	$0.3 \times V_{DD}$	$0.5 \times V_{DD}$	$0.7 \times V_{DD}$	4.71 R <sub>t</sub> C <sub>t</sub>	4.40 R <sub>t</sub> C <sub>t</sub>	4.71 R <sub>t</sub> C <sub>t</sub>			
V <sub>DD</sub> = 15 V	4 V	$0.5 \times V_{DD}$	11 V	4.84 R <sub>t</sub> C <sub>t</sub>	4.40 R <sub>t</sub> C <sub>t</sub>	4.84 R <sub>t</sub> C <sub>t</sub>			

[1] Therefore if  $t_A$  = 4.40  $R_tC_t$  is used, the maximum variation is (+7.0%; -0.0%) at 10 V.

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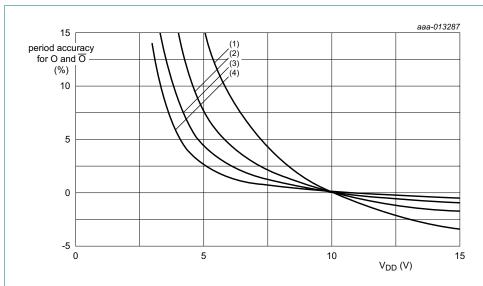
### 11.1.2 Variations due to changes in V<sub>DD</sub>

In addition to variations from unit-to-unit, the astable period may vary as a function of frequency with respect to  $V_{DD}$ . Typical variations are presented graphically in <u>Figure 7</u> and <u>Figure 8</u> with 10 V as a reference.



- (2)  $T_{amb} = 25 \text{ °C}$ ;  $f_o = 5 \text{ kHz}$ ;  $C_t = 100 \text{ pF}$ ;  $R_t = 470 \text{ k}\Omega$ .
- (3)  $T_{amb}$  = 25 °C;  $f_o$  = 1 kHz;  $C_t$  = 1000 pF;  $R_t$  = 220 k $\Omega$ .

Fig 7. Typical O and O period accuracy as a function of supply voltage; astable mode.

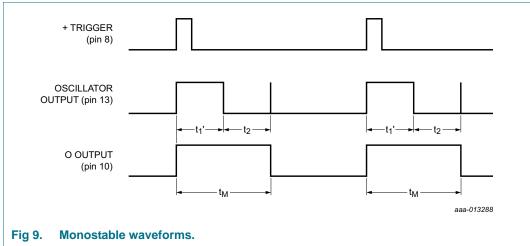


- (1)  $T_{amb} = 25$  °C;  $f_o = 500$  kHz;  $C_t = 10$  pF;  $R_t = 47$  k $\Omega$ .
- (2)  $T_{amb} = 25 \text{ °C}$ ;  $f_o = 225 \text{ kHz}$ ;  $C_t = 100 \text{ pF}$ ;  $R_t = 10 \text{ k}\Omega$ .
- (3)  $T_{amb} = 25 \text{ °C}$ ;  $f_o = 100 \text{ kHz}$ ;  $C_t = 100 \text{ pF}$ ;  $R_t = 22 \text{ k}\Omega$ .
- (4)  $T_{amb} = 25$  °C;  $f_o = 50$  kHz;  $C_t = 100$  pF;  $R_t = 47$  k $\Omega$ .

Fig 8. Typical O and O period accuracy as a function of supply voltage; astable mode.

### 11.2 Monostable mode design information

The following analysis presents worst case variations from unit-to-unit as a function of transfer voltage (V<sub>TR</sub>) shift for one-shot (monostable) operation.



$$t_I' = -R_t C_t \ln \frac{V_{TR}}{2V_{DD}} \tag{4}$$

$$t_M = (t_1' + t_2)$$
 (5)

$$t_{M} = -R_{t}C_{t} \ln \frac{(V_{TR})(V_{DD} - V_{TR})}{(2V_{DD} - V_{TR})(2V_{DD})}$$

$$\tag{6}$$

, where  $t_M$  = monostable mode pulse width; see table <u>Table 11</u>.

Table 11. Values for monostable mode pulse width (t<sub>M</sub>)

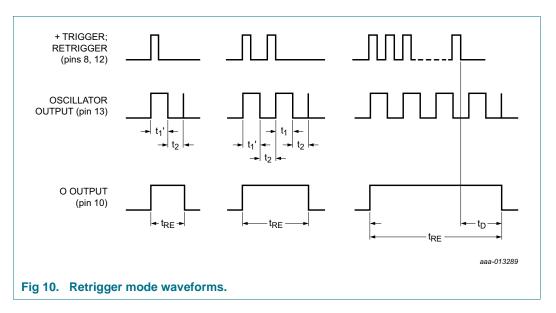
		$V_{TR}$			t <sub>M</sub>	
	Min	Тур	Max	Min	Typ[1]	Max
V <sub>DD</sub> = 5 V or 10 V	$0.3 \times V_{DD}$	$0.5 \times V_{DD}$	$0.7 \times V_{DD}$	2.78 R <sub>t</sub> C <sub>t</sub>	2.48 R <sub>t</sub> C <sub>t</sub>	2.52 R <sub>t</sub> C <sub>t</sub>
V <sub>DD</sub> = 15 V	4 V	$0.5 \times V_{DD}$	11 V	2.88 R <sub>t</sub> C <sub>t</sub>	2.48 R <sub>t</sub> C <sub>t</sub>	2.56 R <sub>t</sub> C <sub>t</sub>

In the astable mode, the first positive half cycle has a duration of t<sub>M</sub>: succeeding durations are ½ t<sub>A</sub>. Therefore if  $t_M = 2.48 R_t C_t$  is used, the maximum variation is (+12%; -0.0%) at 10 V.

#### Monostable/astable multivibrator

### 11.2.1 Retrigger mode operation

The HEF4047B can be used in the retrigger mode to extend the output pulse duration. It can also be used to compare the frequency of an input signal with the frequency of the internal oscillator. In the retrigger mode, the input pulse is applied to pins 8 and 12, and the output is taken from pin 10 or 11. Normal monostable action is obtained when one retrigger pulse is applied (see <u>Figure 10</u>). Extended pulse duration is obtained when more than one pulse is applied. For two input pulses,  $t_{RE} = t_1' + t_1 + 2t_2$ . For more than two pulses,  $t_{RE}$  (output O), terminates at some variable time,  $t_D$ , after the termination of the last retrigger pulse.  $t_D$  is variable because  $t_{RE}$  (output O) terminates after the second positive edge of the oscillator output appears at flip-flop 4.



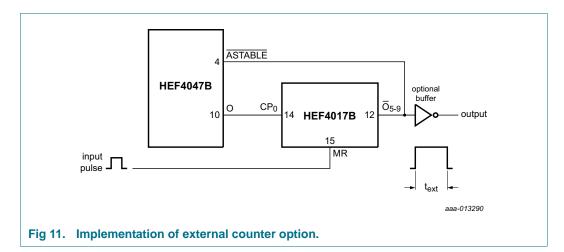
### 11.2.2 External counter option

The use of external counting circuitry extends time  $t_M$  by any amount. Advantages include digitally controlled pulse duration, small timing capacitors for long time periods, and extremely fast recovery time. A typical implementation is shown in Figure 11.

The pulse duration at the output is:

$$t_{ext} = (N-1)(t_A) + (t_M + 1/2 t_A)$$
(7)

Where  $t_{ext}$  = pulse duration of the circuitry, and N is the number of counts used.



### 11.2.3 Timing component limitations

The capacitor used in the circuit should be non-polarized and have low leakage (that is the parallel resistance of the capacitor should be an order of magnitude greater than the external resistor used). There is no upper or lower limit for either  $R_t$  or  $C_t$  value to maintain oscillation. However, for accuracy,  $C_t$  must be much larger than the inherent stray capacitance in the system (unless this capacitance can be measured and taken into account).  $R_t$  must be much larger than the LOCMOS 'ON' resistance in series with it, which typically is hundreds of ohms.

The recommended values for  $R_t$  and  $C_t$  to comply with previously calculated formulae without trimming should be:

- $C_t \ge 100$  pF, up to any practical value
- 10  $k\Omega \le R_t \le 1 M\Omega$

### 11.2.4 Power consumption

In the standby mode (monostable or astable), power dissipation is a function of leakage current in the circuit. For dynamic operation, the power required to charge the external timing capacitor  $C_t$  is shown in the following formulae:

Astable mode:

$$P = 2 C_t V^2 f \qquad (f \text{ at output pin } 13)$$
(8)

$$P = 4 C_t V^2 f \qquad (f \text{ at output pins } 10 \text{ and } 11)$$
 (9)

Monostable mode:

$$P = \frac{(2.9 \text{ C}_t \text{ V}^2)(\text{duty cycle})}{T} \qquad \text{(f at output pins 10 and 11)}$$

Because the power dissipation does not depend on  $R_t$ , a design for minimum power dissipation would be a small value of  $C_t$ . The value of R would depend on the desired period (within the limitations discussed previously). Typical power consumption in astable mode is shown in Figure 12, Figure 13 and Figure 14.

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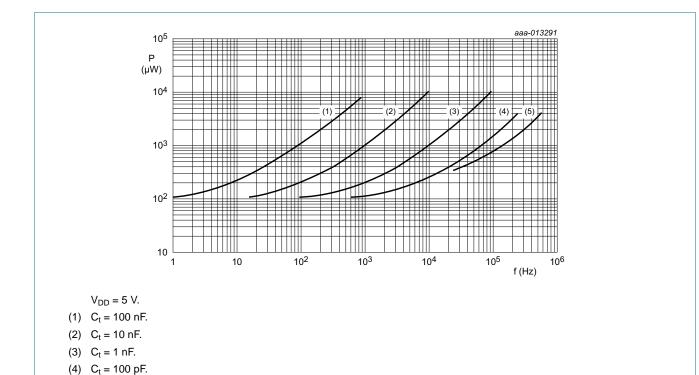
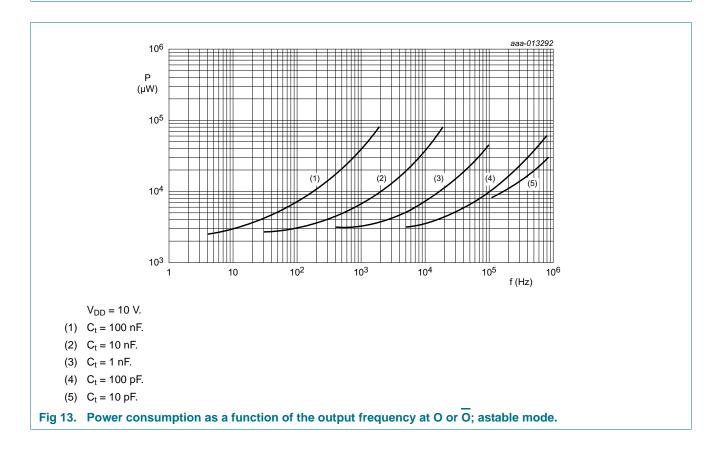
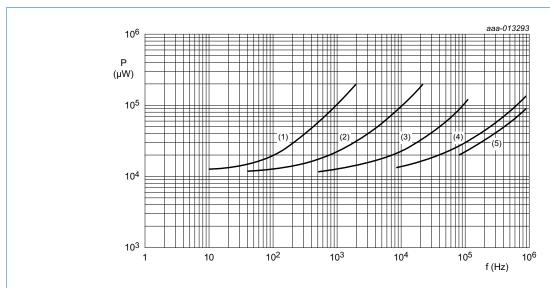


Fig 12. Power consumption as a function of the output frequency at O or  $\overline{O}$ ; astable mode.



(5)  $C_t = 10 \text{ pF}.$ 

### Monostable/astable multivibrator



 $V_{DD} = 15 \text{ V}.$ 

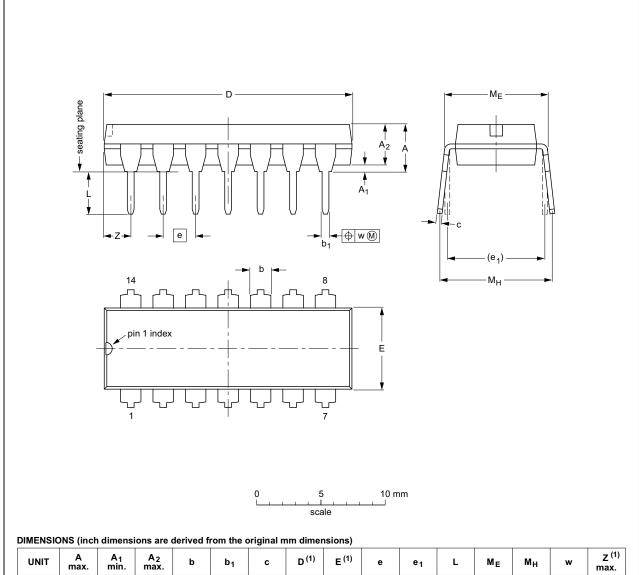
- (1)  $C_t = 100 \text{ nF}.$
- (2)  $C_t = 10 \text{ nF}.$
- (3)  $C_t = 1 \text{ nF}.$
- (4)  $C_t = 100 \text{ pF}.$
- (5)  $C_t = 10 \text{ pF}.$

Fig 14. Power consumption as a function of the output frequency at O or  $\overline{O}$ ; astable mode.

# 12. Package outline

DIP14: plastic dual in-line package; 14 leads (300 mil)

SOT27-1



UNIT	A max.	A <sub>1</sub> min.	A <sub>2</sub> max.	b	b <sub>1</sub>	С	D <sup>(1)</sup>	E <sup>(1)</sup>	е	e <sub>1</sub>	L	ME	Мн	w	Z <sup>(1)</sup> max.
mm	4.2	0.51	3.2	1.73 1.13	0.53 0.38	0.36 0.23	19.50 18.55	6.48 6.20	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	2.2
inches	0.17	0.02	0.13	0.068 0.044	0.021 0.015	0.014 0.009	0.77 0.73	0.26 0.24	0.1	0.3	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.087

### Note

1. Plastic or metal protrusions of 0.25 mm (0.01 inch) maximum per side are not included.

	REFER	EUROPEAN	ISSUE DATE			
IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE	
050G04	MO-001	SC-501-14			<del>99-12-27</del> 03-02-13	
_		IEC JEDEC		IEC JEDEC JEITA	IEC JEDEC JEITA PROJECTION	

Fig 15. Package outline SOT27-1 (DIP14)

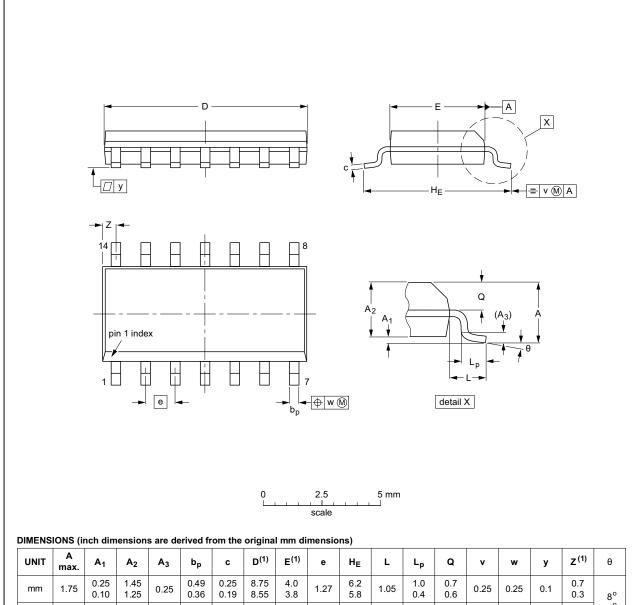
HEF4047E

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### SO14: plastic small outline package; 14 leads; body width 3.9 mm

SOT108-1



UNIT	Γ A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	bp	С	D <sup>(1)</sup>	E <sup>(1)</sup>	е	HE	L	Lp	Q	v	w	у	Z <sup>(1)</sup>	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	8.75 8.55	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8°
inche	es 0.069	0.010 0.004	0.057 0.049	0.01		0.0100 0.0075	0.35 0.34	0.16 0.15	0.05	0.244 0.228	0.041	0.039 0.016	0.028 0.024	0.01	0.01	0.004	0.028 0.012	0°

#### Note

1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT108-1	076E06	MS-012				<del>99-12-27</del> 03-02-19

Fig 16. Package outline SOT108-1 (SO14)

HEF4047B

### Monostable/astable multivibrator

# 13. Revision history

### Table 12. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes				
HEF4047B v.4	20140915	HEF4047B_CVN_3						
Modifications:		<ul> <li>The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li> </ul>						
	<ul> <li>Legal texts ha</li> </ul>	<ul> <li>Legal texts have been adapted to the new company name where appropriate.</li> </ul>						
HEF4047B_CVN_3	19950101	Product specification	-	-				

#### Monostable/astable multivibrator

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Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <a href="http://www.nxp.com">http://www.nxp.com</a>.

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